

54F/74F00

Quad 2-Input NAND Gate

General Description

This device contains four independent gates, each of which performs the logic NAND function.

Features

- Guaranteed 4000V minimum ESD protection

Ordering Code:

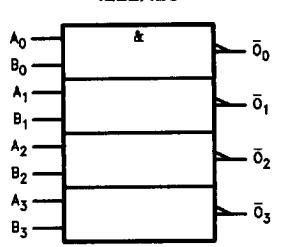
See Section 11

Commercial	Military	Package Number	Package Description
74F00PC		N14A	14-Lead (0.300" Wide) Molded Dual-In-Line
	54F00DM (Note 2)	J14A	14-Lead Ceramic Dual-In-Line
74F00SC (Note 1)		M14A	14-Lead (0.150" Wide) Molded Small Outline, JEDEC
74F00SJ (Note 1)		M14D	14-Lead (0.300" Wide) Molded Small Outline, EIAJ
	54F00FM (Note 2)	W14B	14-Lead Cerpack
	54F00LM (Note 2)	E20A	20-Lead Ceramic Leadless Chip Carrier, Type C

Note 1: Devices also available in 13" reel. Use suffix = SCX and SJX.

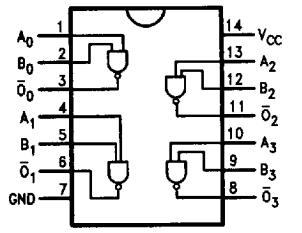
Note 2: Military grade device with environmental and burn-in processing. Use suffix = DMQB, FMQB and LMQB.

Logic Symbol



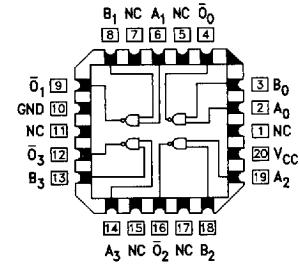
TL/F/9454-3

Pin Assignment for DIP, SOIC and Flatpak



TL/F/9454-2

Pin Assignment for LCC



TL/F/9454-1

Unit Loading/Fan Out:

See Section 2 for U.L. definitions

Pin Names	Description	54F/74F	
		U.L. HIGH/LOW	Input I_{IH}/I_{IL} Output I_{OH}/I_{OL}
A _n , B _n \bar{O}_n	Inputs Outputs	1.0/1.0 50/33.3	20 μ A/-0.6 mA -1 mA/20 mA

Absolute Maximum Ratings (Note 1)

Storage Temperature	−65°C to +150°C		
Ambient Temperature under Bias	−55°C to +125°C		
Junction Temperature under Bias Plastic	−55°C to +175°C −55°C to +150°C		
V _{CC} Pin Potential to Ground Pin	−0.5V to +7.0V		
Input Voltage (Note 2)	−0.5V to +7.0V		
Input Current (Note 2)	−30 mA to +5.0 mA		
Voltage Applied to Output in HIGH State (with V _{CC} = 0V)	−0.5V to V _{CC}		
Standard Output	−0.5V to +5.5V		
TRI-STATE® Output			
Current Applied to Output in LOW State (Max)	twice the rated I _{OL} (mA)		
ESD Last Passing Voltage (Min)	4000V		

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

Recommended Operating Conditions

Free Air Ambient Temperature Commercial	0°C to +70°C
Supply Voltage Commercial	+4.5V to +5.5V

DC Electrical Characteristics

Symbol	Parameter	54F/74F			Units	V _{CC}	Conditions
		Min	Typ	Max			
V _{IH}	Input HIGH Voltage	2.0			V		Recognized as a HIGH Signal
V _{IL}	Input LOW Voltage		0.8		V		Recognized as a LOW Signal
V _{CD}	Input Clamp Diode Voltage		−1.2		V	Min	I _{IN} = −18 mA
V _{OH}	Output HIGH Voltage	54F 10% V _{CC} 74F 10% V _{CC} 74F 5% V _{CC}	2.5 2.5 2.7		V	Min	I _{OH} = −1 mA I _{OH} = −1 mA I _{OH} = −1 mA
V _{OL}	Output LOW Voltage	54F 10% V _{CC} 74F 10% V _{CC}		0.5 0.5	V	Min	I _{OL} = 20 mA I _{OL} = 20 mA
I _{IH}	Input HIGH Current	54F 74F		20.0 5.0	μA	Max	V _{IN} = 2.7V
I _{BVI}	Input HIGH Current Breakdown Test	54F 74F		100 7.0	μA	Max	V _{IN} = 7.0V
I _{CEx}	Output HIGH Leakage Current	54F 74F		250 50	μA	Max	V _{OUT} = V _{CC}
V _{ID}	Input Leakage Test	74F	4.75		V	0.0	I _{ID} = 1.9 μA All other pins grounded
I _{OD}	Output Leakage Circuit Current	74F		3.75	μA	0.0	V _{IOD} = 150 mV All other pins grounded
I _{IL}	Input LOW Current			−0.6	mA	Max	V _{IN} = 0.5V
I _{OS}	Output Short-Circuit Current		−60	−150	mA	Max	V _{OUT} = 0V
I _{CCH}	Power Supply Current			1.9	2.8	mA	VO = HIGH
I _{CCL}	Power Supply Current			6.8	10.2	mA	VO = LOW

AC Electrical Characteristics: See Section 2 for Waveforms and Load Configurations

Symbol	Parameter	74F		54F		74F		Units	Fig. No.		
		$T_A = +25^\circ C$		$T_A, V_{CC} = \text{Mil}$		$T_A, V_{CC} = \text{Com}$					
		$V_{CC} = +5.0V$	$C_L = 50 \text{ pF}$	$C_L = 50 \text{ pF}$	$C_L = 50 \text{ pF}$	$C_L = 50 \text{ pF}$	$C_L = 50 \text{ pF}$				
t_{PLH}	Propagation Delay A_n, B_n to \bar{Q}_n	2.4 1.5	3.7 3.2	5.0 4.3	2.0 1.5	7.0 6.5	2.4 1.5	6.0 5.3	ns	2-3	